

## **Data Sheet**

# Hot Swappable, Dual I<sup>2</sup>C Isolators

# ADuM1250/ADuM1251

### FEATURES

Bidirectional I<sup>2</sup>C communication Open-drain interfaces Suitable for hot swap applications 30 mA current sink capability 1000 kHz operation 3.0 V to 5.5 V supply/logic levels 8-lead, RoHS compliant SOIC package High temperature operation: 125°C Qualified for automotive applications Safety and regulatory approvals

#### **UL** recognition

2500 V rms for 1 minute per UL 1577 CSA Component Acceptance Notice 5A VDE certificate of conformity DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 V<sub>IORM</sub> = 560 V peak

#### **APPLICATIONS**

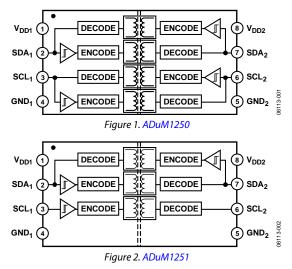
Isolated I<sup>2</sup>C, SMBus, or PMBus interfaces Multilevel I<sup>2</sup>C interfaces Power supplies Networking Power over Ethernet Hybrid electric vehicle battery management

#### **GENERAL DESCRIPTION**

The ADuM1250/ADuM1251<sup>1</sup> are hot swappable digital isolators with nonlatching, bidirectional communication channels that are compatible with I<sup>2</sup>C interfaces. This eliminates the need for splitting I<sup>2</sup>C signals into separate transmit and receive signals for use with standalone optocouplers.

The ADuM1250 provides two bidirectional channels, supporting a complete isolated I<sup>2</sup>C interface. The ADuM1251 provides one bidirectional channel and one unidirectional channel for applications where a bidirectional clock is not required.





Both the ADuM1250 and the ADuM1251 contain hot swap circuitry to prevent glitching data when an unpowered card is inserted onto an active bus.

These isolators are based on the *i*Coupler<sup>®</sup> chip scale transformer technology from Analog Devices, Inc. *i*Coupler is a magnetic isolation technology with functional, performance, size, and power consumption advantages as compared to optocouplers. With the ADuM1250/ADuM1251, *i*Coupler channels can be integrated with semiconductor circuitry, which enables a complete isolated I<sup>2</sup>C interface to be implemented in a small form factor.

<sup>1</sup> Protected by U.S. Patents 5,952,849; 6,873,065; and 7,075,329.

#### Rev. H

#### Document Feedback

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## **REVISION HISTORY**

7/15—Rev. G to Rev. H	
Changes to Table 4 and Table 5	5

#### 3/14—Rev. F to Rev. G

Moved Typical Application Diagram Section	11
Added Capacitive Load at Low Speeds Section and Table 11	11
Moved Magnetic Field Immunity Section	12
Changes to Ordering Guide	13

#### 9/12-Rev. E to Rev. F

Created Hyperlink for Safety and Regulatory Approvals
Entry in Features Section 1
Changes to Ordering Guide 12

### 12/11—Rev. D to Rev. E

Change to Ordering Guide1	2
Changes to Automotive Products Section 1	2

#### 7/11-Rev. C to Rev. D

Change to Typical Application Diagram Section......11

#### 5/10—Rev. B to Rev. C

Changes to Features Section and Applications Section
Changed $V_{DD1} = 5$ V, and $V_{DD2} = 5$ V to $V_{DD1} = 3.3$ V or 5 V,
and $V_{DD2} = 3.3 \text{ V or } 5 \text{ V}$
Changed $V_{DD1} = 5$ V, and $V_{DD2} = 5$ V to $V_{DD1} = 3.3$ V or 5 V,
and $V_{DD2} = 3.3$ V or 5 V
Changes to Typical Application Diagram Section
and Figure 9 11
Changes to Ordering Guide 12
Added Automotive Products Section 12

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### 12/09—Rev. A to Rev. B

Changes to Features Section1
Changes to Operating Temperature (TA) Parameter, Table 76
Changes to Ambient Operating Temperature (T <sub>A</sub> ) Parameter,
Table 87
Changes to Ordering Guide 12

#### 6/07—Rev. 0 to Rev. A

Updated VDE Certification Throughout	1
Changes to Features and Note 1	
Changes to Table 4 and Table 5	
Changes to Table 6	
Updated Outline Dimensions	
Changes to Ordering Guide	

10/06—Revision 0: Initial Version

## **SPECIFICATIONS**

### **ELECTRICAL CHARACTERISTICS**

#### **DC Specifications**<sup>1</sup>

All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at  $T_A = 25^{\circ}$ C,  $V_{DD1} = 3.3$  V or 5 V, and  $V_{DD2} = 3.3$  V or 5 V, unless otherwise noted.

Parameter	Symbol	Min	Тур	Max	Unit	<b>Test Conditions/Comments</b>
ADuM1250						
Input Supply Current, Side 1, 5 V	I <sub>DD1</sub>		2.8	5.0	mA	$V_{DD1} = 5 V$
Input Supply Current, Side 2, 5 V	I <sub>DD2</sub>		2.7	5.0	mA	$V_{DD2} = 5 V$
Input Supply Current, Side 1, 3.3 V	I <sub>DD1</sub>		1.9	3.0	mA	$V_{DD1} = 3.3 V$
Input Supply Current, Side 2, 3.3 V	I <sub>DD2</sub>		1.7	3.0	mA	$V_{DD2} = 3.3 V$
ADuM1251						
Input Supply Current, Side 1, 5 V	I <sub>DD1</sub>		2.8	6.0	mA	$V_{DD1} = 5 V$
Input Supply Current, Side 2, 5 V	I <sub>DD2</sub>		2.5	4.7	mA	$V_{DD2} = 5 V$
Input Supply Current, Side 1, 3.3 V	I <sub>DD1</sub>		1.8	3.0	mA	$V_{DD1} = 3.3 V$
Input Supply Current, Side 2, 3.3 V	I <sub>DD2</sub>		1.6	2.8	mA	$V_{DD2} = 3.3 V$
LEAKAGE CURRENTS	Isda1, Isda2, Iscl1, Iscl2		0.01	10	μΑ	$V_{SDA1} = V_{DD1}, V_{SDA2} = V_{DD2},$ $V_{SCL1} = V_{DD1}, V_{SCL2} = V_{DD2}$
SIDE 1 LOGIC LEVELS						
Logic Input Threshold <sup>2</sup>	VSDA1T, VSCL1T	500		700	mV	
Logic Low Output Voltages	VSDA10L, VSCL10L	600		900	mV	$I_{SDA1} = I_{SCL1} = 3.0 \text{ mA}$
		600		850	mV	$I_{SDA1} = I_{SCL1} = 0.5 \text{ mA}$
Input/Output Logic Low Level Difference <sup>3</sup>	$\Delta V_{SDA1}, \Delta V_{SCL1}$	50			mV	
SIDE 2 LOGIC LEVELS						
Logic Low Input Voltage	VSDA2IL, VSCL2IL			0.3 V <sub>DD2</sub>	v	
Logic High Input Voltage	V <sub>SDA2IH</sub> , V <sub>SCL2IH</sub>	$0.7 V_{DD2}$			v	
Logic Low Output Voltage	VSDA2OL, VSCL2OL			400	mV	$I_{SDA2} = I_{SCL2} = 30 \text{ mA}$

<sup>1</sup> All voltages are relative to their respective ground.

 $^{2}$  V<sub>IL</sub> < 0.5 V, V<sub>IH</sub> > 0.7 V.

<sup>3</sup>  $\Delta V_{s1} = V_{s10L} - V_{s1T}$ . This is the minimum difference between the output logic low level and the input logic threshold within a given component. This ensures that there is no possibility of the part latching up the bus to which it is connected.

## ADuM1250/ADuM1251

#### AC Specifications<sup>1</sup>

All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at  $T_A = 25^{\circ}$ C,  $V_{DD1} = 3.3$  V or 5 V, and  $V_{DD2} = 3.3$  V or 5 V, unless otherwise noted. Refer to Figure 5.

Table 2.						
Parameter	Symbol	Min	Тур	Max	Unit	<b>Test Conditions/Comments</b>
MAXIMUM FREQUENCY		1000			kHz	
OUTPUT FALL TIME						
5 V Operation						$\begin{array}{l} \text{4.5 V} \leq V_{\text{DD1}}, V_{\text{DD2}} \leq 5.5 \text{ V}, \text{ C}_{\text{L1}} = 40 \text{ pF}, \\ \text{R1} = 1.6 \text{ k}\Omega, \text{ C}_{\text{L2}} = 400 \text{ pF}, \text{R2} = 180 \ \Omega \end{array}$
Side 1 Output (0.9 V <sub>DD1</sub> to 0.9 V)	t <sub>f1</sub>	13	26	120	ns	
Side 2 Output (0.9 $V_{DD2}$ to 0.1 $V_{DD2}$ )	t <sub>f2</sub>	32	52	120	ns	
3 V Operation						$\begin{array}{l} 3.0 \; V \leq V_{DD1},  V_{DD2} \leq 3.6 \; V,  C_{L1} = 40 \; pF, \\ R1 = 1.0 \; k\Omega,  C_{L2} = 400 \; pF,  R2 = 120 \; \Omega \end{array}$
Side 1 Output (0.9 V <sub>DD1</sub> to 0.9 V)	t <sub>f1</sub>	13	32	120	ns	
Side 2 Output (0.9 $V_{DD2}$ to 0.1 $V_{DD2}$ )	t <sub>f2</sub>	32	61	120	ns	
PROPAGATION DELAY						
5 V Operation						$\begin{array}{l} 4.5 \leq V_{DD1}, V_{DD2} \leq 5.5 \ V, \ C_{L1} = C_{L2} = 0 \ pF, \\ R1 = 1.6 \ k\Omega, \ R2 = 180 \ \Omega \end{array}$
Side 1 to Side 2, Rising Edge <sup>2</sup>	t <sub>PLH12</sub>		95	130	ns	
Side 1 to Side 2, Falling Edge <sup>3</sup>	t <sub>PHL12</sub>		162	275	ns	
Side 2 to Side 1, Rising Edge <sup>4</sup>	t <sub>PLH21</sub>		31	70	ns	
Side 2 to Side 1, Falling Edge⁵	t <sub>PHL21</sub>		85	155	ns	
3 V Operation						$\begin{array}{l} 3.0 \ V \leq V_{DD1}, \ V_{DD2} \leq 3.6 \ V, \ C_{L1} = C_{L2} = 0 \ pF, \\ R1 = 1.0 \ k\Omega, \ R2 = 120 \ \Omega \end{array}$
Side 1 to Side 2, Rising Edge <sup>2</sup>	t <sub>PLH12</sub>		82	125	ns	
Side 1 to Side 2, Falling Edge <sup>3</sup>	t <sub>PHL12</sub>		196	340	ns	
Side 2 to Side 1, Rising Edge <sup>4</sup>	t <sub>PLH21</sub>		32	75	ns	
Side 2 to Side 1, Falling Edge⁵	t <sub>PHL21</sub>		110	210	ns	
PULSE WIDTH DISTORTION						
5 V Operation						$ \begin{array}{l} 4.5 \ V \leq V_{DD1}, V_{DD2} \leq 5.5 \ V, \ C_{L1} = C_{L2} = 0 \ pF, \\ R1 = 1.6 \ k\Omega, \ R2 = 180 \ \Omega \end{array} $
Side 1 to Side 2, tPLH12 – tPHL12	PWD <sub>12</sub>		67	145	ns	
Side 2 to Side 1,  t <sub>PLH21</sub> – t <sub>PHL21</sub>	PWD <sub>21</sub>		54	85	ns	
3 V Operation						$\begin{array}{l} 3.0 \ V \leq V_{DD1}, \ V_{DD2} \leq 3.6 \ V, \ C_{L1} = C_{L2} = 0 \ pF, \\ R1 = 1.0 \ k\Omega, \ R2 = 120 \ \Omega \end{array}$
Side 1 to Side 2, $ t_{PLH12} - t_{PHL12} $	PWD <sub>12</sub>		114	215	ns	
Side 2 to Side 1, t <sub>PLH21</sub> – t <sub>PHL21</sub>	PWD <sub>21</sub>		77	135	ns	
COMMON-MODE TRANSIENT IMMUNITY <sup>6</sup>	CMH, CML	25	35		kV/μs	

<sup>1</sup> All voltages are relative to their respective ground.

 $^{2}$  t<sub>PLH12</sub> propagation delay is measured from the Side 1 input logic threshold to an output value of 0.7 V<sub>DD2</sub>.

 $^{3}$  t<sub>PHL12</sub> propagation delay is measured from the Side 1 input logic threshold to an output value of 0.4 V.

 $^4$  t<sub>PLH21</sub> propagation delay is measured from the Side 2 input logic threshold to an output value of 0.7 V<sub>DD1</sub>.

 $^{5}$  t<sub>PHL21</sub> propagation delay is measured from the Side 2 input logic threshold to an output value of 0.9 V.

<sup>6</sup> CM<sub>H</sub> is the maximum common-mode voltage slew rate that can be sustained while maintaining V<sub>0</sub> > 0.8 V<sub>DD2</sub>. CM<sub>L</sub> is the maximum common-mode voltage slew rate that can be sustained while maintaining V<sub>0</sub> < 0.8 V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges. The transient magnitude is the range over which the common mode is slewed.

### PACKAGE CHARACTERISTICS

#### Table 3.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
Resistance (Input to Output) <sup>1</sup>	RI-O		10 <sup>12</sup>		Ω	
Capacitance (Input to Output) <sup>1</sup>	CI-O		1.0		рF	f = 1 MHz
Input Capacitance	Cı		4.0		рF	
IC Junction to Case Thermal Resistance, Side 1	θ」		46		°C/W	Thermocouple located at center of package underside
IC Junction to Case Thermal Resistance, Side 2	θιco		41		°C/W	

<sup>1</sup> The device is considered a 2-terminal device; Pin 1 through Pin 4 are shorted together, and Pin 5 through Pin 8 are shorted together.

### **REGULATORY INFORMATION**

The ADuM1250/ADuM1251 have been approved by the organizations listed in Table 4.

#### Table 4.

UL	CSA	CQC	VDE
Recognized Under 1577 Component Recognition Program <sup>1</sup>	Approved under CSA Component Acceptance Notice 5A	Approved under CQC11-471543-2012	Certified according to DIN V VDE V 0884-10 (VDE V 0884-10): 2006-12 <sup>2</sup>
Single/Basic 2500 V rms Isolation Voltage	Reinforced insulation per CSA 60950-1-03 and IEC 60950-1, 125 V rms (177 V peak) maximum working voltage Basic insulation per CSA 60950-1-03 and IEC 60950-1, 400 V rms (566 V peak) maximum working voltage	Basic insulation per GB4943.1-2011, 400 V rms (566 V peak) maximum working voltage, tropical climate, altitude ≤ 5000 m	Reinforced insulation, 560 V peak
File E214100	File 205078	File CQC14001108691	File 2471900-4880-0001

<sup>1</sup> In accordance with UL 1577, each ADuM1250/ADuM1251 is proof tested by applying an insulation test voltage  $\geq$  3000 V rms for 1 second (current leakage detection limit = 5  $\mu$ A).

 $2^{-1}$  In accordance with DIN V VDE V 0884-10, each ADuM1250/ADuM1251 is proof tested by applying an insulation test voltage  $\geq$  1050 V peak for 1 sec (partial discharge detection limit = 5 pC). The asterisk (\*) marking branded on the component designates DIN V VDE V 0884-10 approval.

### INSULATION AND SAFETY RELATED SPECIFICATIONS

#### Table 5.

Parameter	Symbol	Value	Unit	Test Conditions/Comments
Rated Dielectric Insulation Voltage		2500	V rms	1-minute duration
Minimum External Air Gap (Clearance)	L(I01)	4.90 min	mm	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L(102)	4.01 min	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		0.017 min	mm	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>400	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group		Ш		Material Group (DIN VDE 0110, 1/89, Table 1)
Maximum Working Voltage Compatible with 50 Year Service Life	VIORM	565	V peak	Continuous peak voltage across the isolation barrier

### DIN V VDE V 0884-10 (VDE V 0884-10) INSULATION CHARACTERISTICS

This isolator is suitable for reinforced isolation only within the safety limit data. Maintenance of the safety data is ensured by protective circuits. The asterisk (\*) marking on the package denotes DIN V VDE V 0884-10 approval for a 560 V peak working voltage.

Table 6.				
Description	Test Conditions/Comments	Symbol	Characteristic	Unit
Installation Classification per DIN VDE 0110				
For Rated Mains Voltage ≤ 150 V rms			I to IV	
For Rated Mains Voltage ≤ 300 V rms			l to III	
For Rated Mains Voltage ≤ 400 V rms			l to ll	
Climatic Classification			40/105/21	
Pollution Degree per DIN VDE 0110, Table 1			2	
Maximum Working Insulation Voltage		VIORM	560	V peak
Input to Output Test Voltage, Method B1	$V_{IORM} \times 1.875 = V_{PR}$ , 100% production test, $t_m = 1$ sec, partial discharge < 5 pC	Vpr	1050	V peak
Input to Output Test Voltage, Method A	$V_{IORM} \times 1.6 = V_{PR}$ , t <sub>m</sub> = 60 sec, partial discharge < 5 pC	VPR		
After Environmental Tests Subgroup 1			896	V peak
After Input and/or Safety Tests Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{PR}$ , $t_m = 60$ sec, partial discharge < 5 pC		672	V peak
Highest Allowable Overvoltage	Transient overvoltage, t <sub>TR</sub> = 10 sec	VTR	4000	V peak
Safety Limiting Values	Maximum value allowed in the event of a failure (see Figure 3)			
Case Temperature		Ts	150	°C
V <sub>DD1</sub> + V <sub>DD2</sub> Current		I <sub>TMAX</sub>	212	mA
Insulation Resistance at Ts	$V_{IO} = 500 \text{ V}$	Rs	>109	Ω

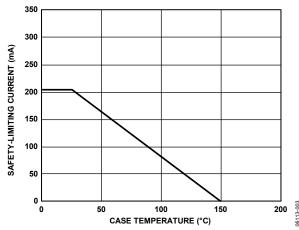


Figure 3. Thermal Derating Curve, Dependence of Safety-Limiting Values on Case Temperature, per DIN V VDE V 0884-10

### **RECOMMENDED OPERATING CONDITIONS**

Table 7.	
Parameter	Rating
Operating Temperature (T <sub>A</sub> )	
A Grade	-40°C to +105°C
S Grade	-40°C to +125°C
Supply Voltages (V <sub>DD1</sub> , V <sub>DD2</sub> ) <sup>1</sup>	3.0 V to 5.5 V
Input/Output Signal Voltage	5.5 V
(V <sub>SDA1</sub> , V <sub>SCL1</sub> , V <sub>SDA2</sub> , V <sub>SCL2</sub> )	
Capacitive Load	
Side 1 (C <sub>L1</sub> )	40 pF
Side 2 (CL2)	400 pF
Static Output Loading	
Side 1 (Isda1, Iscl1)	0.5 mA to 3 mA
Side 2 (Isda2, Iscl2)	0.5 mA to 30 mA

<sup>1</sup> All voltages are relative to their respective ground. See the Magnetic Field Immunity section for information about immunity to external magnetic fields.

## **ABSOLUTE MAXIMUM RATINGS**

Ambient temperature = 25°C, unless otherwise noted.

#### Table 8.

Parameter	Rating		
Storage Temperature (T <sub>ST</sub> )	–55°C to +150°C		
Ambient Operating Temperature (T <sub>A</sub> )			
A Grade	-40°C to +105°C		
S Grade	-40°C to +125°C		
Supply Voltages (V <sub>DD1</sub> , V <sub>DD2</sub> ) <sup>1</sup>	–0.5 V to +7.0 V		
Input/Output Voltage,			
Side 1 (V <sub>SDA1</sub> , V <sub>SCL1</sub> ) <sup>2</sup>	-0.5 V to V <sub>DD1</sub> + 0.5 V		
Side 2 (V <sub>SDA2</sub> , V <sub>SCL2</sub> ) <sup>2</sup>	-0.5 V to V <sub>DD2</sub> + 0.5 V		
Average Output Current per Pin <sup>2</sup>			
Side 1 (I <sub>01</sub> )	±18 mA		
Side 2 (I <sub>O2</sub> )	±100 mA		
Common-Mode Transients <sup>3</sup>	–100 kV/µs to +100 kV/µs		

<sup>1</sup> All voltages are relative to their respective ground.

<sup>2</sup> See Figure 3 for maximum rated current values for various temperatures.
<sup>3</sup> Refers to common-mode transients across the insulation barrier. Common-

mode transients exceeding the absolute maximum rating may cause latch-up or permanent damage.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**



Figure 4. ADuM1250/ADuM1251 Pin Configuration

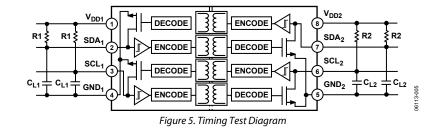
Table 7. ADulti1250 Thi Tunction Descriptions					
No. Mnemonic Description					
V <sub>DD1</sub>	Supply Voltage, 3.0 V to 5.5 V.				
SDA <sub>1</sub>	Data Input/Output, Side 1.				
SCL1	Clock Input/Output, Side 1.				
GND1	Ground 1. Ground reference for Isolator Side 1.				
GND <sub>2</sub>	Ground 2. Isolated ground reference for Isolator Side 2.				
SCL <sub>2</sub>	Clock Input/Output, Side 2.				
SDA <sub>2</sub>	Data Input/Output, Side 2.				
V <sub>DD2</sub>	Supply Voltage, 3.0 V to 5.5 V.				
	Mnemonic       VDD1       SDA1       SCL1       GND1       GND2       SCL2       SDA2	MnemonicDescriptionVDD1Supply Voltage, 3.0 V to 5.5 V.SDA1Data Input/Output, Side 1.SCL1Clock Input/Output, Side 1.GND1Ground 1. Ground reference for Isolator Side 1.GND2Ground 2. Isolated ground reference for Isolator Side 2.SCL2Clock Input/Output, Side 2.DA2Data Input/Output, Side 2.			

#### Table 9. ADuM1250 Pin Function Descriptions

#### Table 10. ADuM1251 Pin Function Descriptions

Pin No.	Mnemonic Description			
1	V <sub>DD1</sub>	Supply Voltage, 3.0 V to 5.5 V.		
2	SDA1	Data Input/Output, Side 1.		
3	SCL1	Clock Input, Side 1.		
4	GND <sub>1</sub>	Ground 1. Ground reference for Isolator Side 1.		
5	GND <sub>2</sub>	Ground 2. Isolated ground reference for Isolator Side 2.		
6	SCL <sub>2</sub>	Clock Output, Side 2.		
7	SDA <sub>2</sub>	Data Input/Output, Side 2.		
8	V <sub>DD2</sub>	Supply Voltage, 3.0 V to 5.5 V.		

## **TEST CONDITIONS**



## **APPLICATIONS INFORMATION** FUNCTIONAL DESCRIPTION

The ADuM1250/ADuM1251 interface on each side to a bidirectional I<sup>2</sup>C signal. Internally, the I<sup>2</sup>C interface is split into two unidirectional channels communicating in opposing directions via a dedicated *i*Coupler isolation channel for each. One channel (the bottom channel of each channel pair shown in Figure 6) senses the voltage state of the Side 1 I<sup>2</sup>C pin and transmits its state to its respective Side 2 I<sup>2</sup>C pin.

Both the Side 1 and the Side 2  $I^2C$  pins are designed to interface to an  $I^2C$  bus operating in the 3.0 V to 5.5 V range. A logic low on either pin causes the opposite pin to be pulled low enough to comply with the logic low threshold requirements of other  $I^2C$ devices on the bus. Avoidance of  $I^2C$  bus contention is ensured by an input low threshold at SDA<sub>1</sub> or SCL<sub>1</sub> guaranteed to be at least 50 mV less than the output low signal at the same pin. This prevents an output logic low at Side 1 being transmitted back to Side 2 and pulling down the  $I^2C$  bus.

Because the Side 2 logic levels/thresholds are standard I<sup>2</sup>C values, multiple ADuM1250/ADuM1251 devices connected to a bus by their Side 2 pins can communicate with each other and with other I<sup>2</sup>C compatible devices. A distinction is made between I<sup>2</sup>C compatibility and I<sup>2</sup>C compliance. I<sup>2</sup>C compatibility refers to situations in which the logic levels of a component do not necessarily meet the requirements of the I<sup>2</sup>C specification but still allow the component to communicate with an I<sup>2</sup>C compliant device. I<sup>2</sup>C compliance refers to situations in which the logic levels of a component meet the requirements of the I<sup>2</sup>C specification.

However, because the Side 1 pin has a modified output level/ input threshold, this side of the ADuM1250/ADuM1251 can communicate only with devices that conform to the I<sup>2</sup>C standard. In other words, Side 2 of the ADuM1250/ADuM1251 is I<sup>2</sup>C compliant, whereas Side 1 is only I<sup>2</sup>C compatible.

The output logic low levels are independent of the  $V_{\rm DD1}$  and  $V_{\rm DD2}$  voltages. The input logic low threshold at Side 1 is also independent of  $V_{\rm DD1}$ . However, the input logic low threshold at Side 2 is designed to be at 0.3  $V_{\rm DD2}$ , consistent with I<sup>2</sup>C requirements. The Side 1 and Side 2 pins have open-collector outputs whose high levels are set via pull-up resistors to their respective supply voltages.

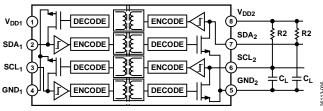


Figure 6. ADuM1250 Block Diagram

## STARTUP

Both the  $V_{DD1}$  and  $V_{DD2}$  supplies have an undervoltage lockout feature to prevent the signal channels from operating unless certain criteria are met. This feature prevents input logic low signals from pulling down the I<sup>2</sup>C bus inadvertently during power-up/power-down.

For the signal channels to be enabled, the following two criteria must be met:

- Both supplies must be at least 2.5 V.
- At least 40 µs must elapse after both supplies exceed the internal startup threshold of 2.0 V.

Until both criteria are met for both supplies, the ADuM1250/ ADuM1251 outputs are pulled high, ensuring a startup that avoids any disturbances on the bus. Figure 7 and Figure 8 illustrate the supply conditions for fast and slow input supply slew rates.

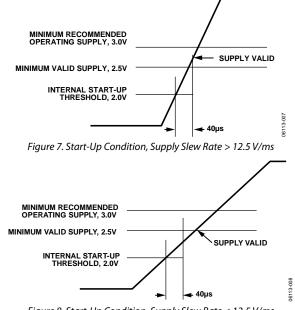


Figure 8. Start-Up Condition, Supply Slew Rate < 12.5 V/ms

### **TYPICAL APPLICATION DIAGRAM**

Figure 9 shows a typical application circuit including the pull-up resistors required for both Side 1 and Side 2 buses. Bypass capacitors with values from 0.01  $\mu$ F to 0.1  $\mu$ F are required between V<sub>DD1</sub> and GND<sub>1</sub> and between V<sub>DD2</sub> and GND<sub>2</sub>. The 200  $\Omega$  resistor shown in Figure 9 is required for latch-up immunity if the ambient temperature can be between 105°C and 125°C.

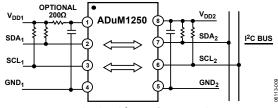


Figure 9. Typical Isolated I<sup>2</sup>C Interface Using the ADuM1250

#### Table 11. Side 1 Maximum Load Conditions

#### **CAPACITIVE LOAD AT LOW SPEEDS**

The ADuM1250/ADuM1251 are designed for operation at speeds up to 1 Mbps. Due to the limited current available on Side 1, operation at 1 Mbps limits the capacitance that can be driven at the minimum pull-up value to 40 pF.

Most applications operate at 100 kbps in standard mode or 400 kbps in fast mode. At these lower operating speeds, the limitation on the load capacitance can be significantly relaxed. Table 11 shows the maximum capacitance at minimum pull-up values for standard and fast operating modes. If larger values for the pull up resistor are used, the maximum supported capacitance must be scaled down proportionately so that the rise time does not increase beyond the values required by the standard.

Maximum Capacitive Load for Side 1							
ModeVData Rate (kbps)tr (ns)tf (ns)R1 (Ω)CL1 (p							
Standard	5	100	1000	187	1600	484	
Fast	5	400	300	172	1600	120	
Standard	3.3	100	1000	270	1000	771	
Fast	3.3	400	300	235	1000	188	

#### **MAGNETIC FIELD IMMUNITY**

The ADuM1250/ADuM1251 are extremely immune to external magnetic fields. The limitation on the magnetic field immunity of the ADuM1250/ADuM1251 is set by the condition in which induced voltage in the receiving coil of the transformer is sufficiently large to either falsely set or reset the decoder. The following analysis defines the conditions under which this may occur. The 3 V operating condition of the ADuM1250/ADuM1251 is examined because it represents the most susceptible mode of operation.

The pulses at the transformer output have an amplitude greater than 1.0 V. The decoder has a sensing threshold at approximately 0.5 V, thus establishing a 0.5 V margin in which induced voltages can be tolerated. The voltage induced across the receiving coil is given by

$$V = (-d\beta/dt) \sum \pi r_n^2; n = 1, 2, \dots, N$$

where:

 $\beta$  is the magnetic flux density (gauss).

 $r_n$  is the radius of the n<sup>th</sup> turn in the receiving coil (cm). *N* is the total number of turns in the receiving coil.

Given the geometry of the receiving coil in the ADuM1250/ ADuM1251 and an imposed requirement that the induced voltage be, at most, 50% of the 0.5 V margin at the decoder, a maximum allowable magnetic field is calculated as shown in Figure 10.

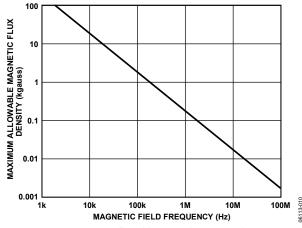
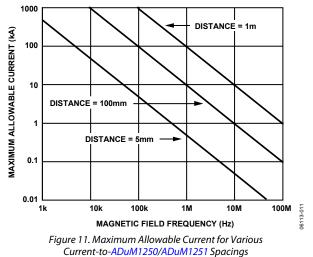


Figure 10. Maximum Allowable External Magnetic Flux Density

For example, at a magnetic field frequency of 1 MHz, the maximum allowable magnetic field of 0.2 kgauss induces a voltage of 0.25 V at the receiving coil. This voltage is approximately 50% of the sensing threshold and does not cause a faulty output transition. Similarly, if such an event occurs during a transmitted pulse (and is of the worst-case polarity), it reduces the received pulse from >1.0 V to 0.75 V, still well above the 0.5 V sensing threshold of the decoder.

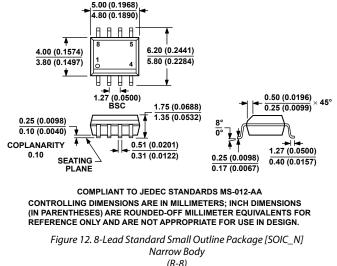
The preceding magnetic flux density values correspond to specific current magnitudes at given distances away from the ADuM1250/ ADuM1251 transformers. Figure 11 expresses these allowable current magnitudes as a function of frequency for selected distances. As shown in Figure 11, the ADuM1250/ADuM1251 are extremely immune and can be affected only by extremely large currents operated at high frequency very close to the component. For the 1 MHz example, a 0.5 kA current placed 5 mm away from the ADuM1250/ADuM1251 is required to affect the operation of the component.



Note that at combinations of strong magnetic field and high frequency, any loops formed by PCB traces can induce error voltages sufficiently large to trigger the thresholds of succeeding circuitry. Exercise care in the layout of such traces to avoid this possibility.

012407-A

## **OUTLINE DIMENSIONS**



(R-8) Dimensions shown in millimeters and (inches)

#### **ORDERING GUIDE**

Model <sup>1, 2</sup>	Number of Inputs, V <sub>DD1</sub> Side	Number of Inputs, V <sub>DD2</sub> Side	Maximum Data Rate (Mbps)	Maximum Propagation Delay (ns)	Temperature Range	Package Description	Package Option
ADuM1250ARZ	2	2	1	150	-40°C to +105°C	8-Lead SOIC_N	R-8
ADuM1250ARZ-RL7	2	2	1	150	-40°C to +105°C	8-Lead SOIC_N	R-8
ADuM1250SRZ	2	2	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8
ADuM1250SRZ-RL7	2	2	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8
ADuM1250WSRZ	2	2	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8
ADuM1250WSRZ-RL7	2	2	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8
ADuM1251ARZ	2	1	1	150	-40°C to +105°C	8-Lead SOIC_N	R-8
ADuM1251ARZ-RL7	2	1	1	150	-40°C to +105°C	8-Lead SOIC_N	R-8
ADuM1251WARZ	2	1	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8
ADuM1251WARZ-RL7	2	1	1	150	-40°C to +125°C	8-Lead SOIC_N	R-8

 $^{1}$  Z = RoHS Compliant Part.

 $^{2}$  W = Qualified for Automotive Applications.

### **AUTOMOTIVE PRODUCTS**

The ADuM1250W and ADuM1251W models are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models; therefore, designers should review the Specifications section of this data sheet carefully. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

## NOTES

## NOTES

## NOTES

I<sup>2</sup>C refers to a communications protocol originally developed by Philips Semiconductors (now NXP Semiconductors).

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